Welcome to E-XFL.COM

Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details	
Product Status	Obsolete
Number of LABs/CLBs	440
Number of Logic Elements/Cells	3520
Total RAM Bits	81920
Number of I/O	12
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	20-UFBGA, WLCSP
Supplier Device Package	20-WLCSP (1.71x2.06)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/ice5lp4k-uwg20itr50

PLB Blocks

The core of the iCE40 Ultra device consists of Programmable Logic Blocks (PLB) which can be programmed to perform logic and arithmetic functions. Each PLB consists of eight interconnected Logic Cells (LC) as shown in Figure 2-2. Each LC contains one LUT and one register.

Figure 2-2. PLB Block Diagram
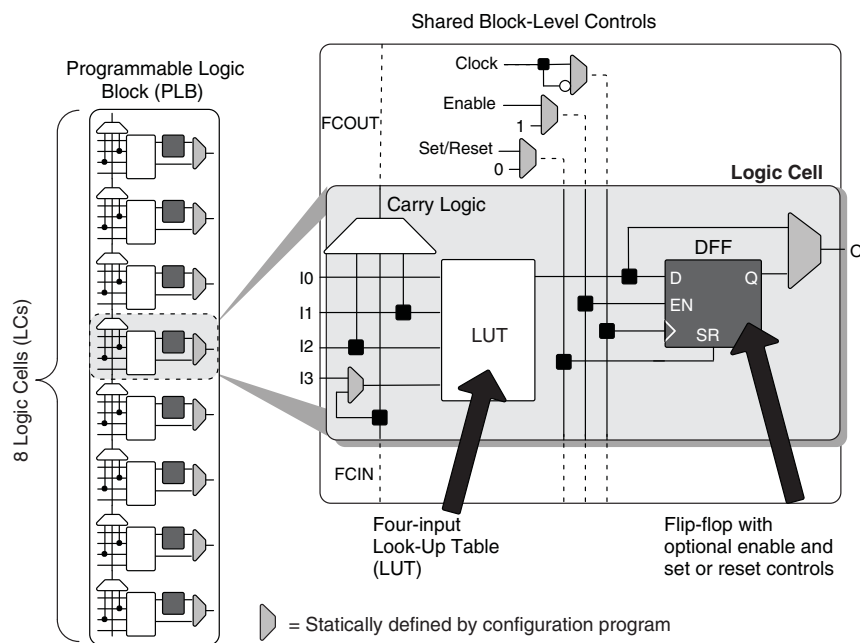
Logic Cells

Each Logic Cell includes three primary logic elements shown in Figure 2-2.

- A four-input Look-Up Table (LUT) builds any combinational logic function, of any complexity, requiring up to four inputs. Similarly, the LUT element behaves as a 16x1 Read-Only Memory (ROM). Combine and cascade multiple LUTs to create wider logic functions.

- A 'D'-style Flip-Flop (DFF), with an optional clock-enable and reset control input, builds sequential logic functions. Each DFF also connects to a global reset signal that is automatically asserted immediately following device configuration.

- Carry Logic boosts the logic efficiency and performance of arithmetic functions, including adders, subtracters, comparators, binary counters and some wide, cascaded logic functions.

Table 2-1. Logic Cell Signal Descriptions

Function	Type	Signal Names	Description
Input	Data signal	I0, I1, I2, I3	Inputs to LUT
Input	Control signal	Enable	Clock enable shared by all LCs in the PLB
Input	Control signal	Set/Reset[1]	Asynchronous or synchronous local set/reset shared by all LCs in the PLB.
Input	Control signal	Clock	Clock one of the eight Global Buffers, or from the general-purpose interconnects fabric shared by all LCs in the PLB
Input	Inter-PLB signal	FCIN	Fast carry in
Output	Data signals	O	LUT or registered output
Output	Inter-PFU signal	FCOUT	Fast carry out

1. If Set/Reset is not used, then the flip-flop is never set/reset, except when cleared immediately after configuration.

Routing

There are many resources provided in the iCE40 Ultra devices to route signals individually with related control signals. The routing resources consist of switching circuitry, buffers and metal interconnect (routing) segments.

The inter-PLB connections are made with three different types of routing resources: Adjacent (spans two PLBs), x4 (spans five PLBs) and x12 (spans thirteen PLBs). The Adjacent, x4 and x12 connections provide fast and efficient connections in the diagonal, horizontal and vertical directions.

The design tool takes the output of the synthesis tool and places and routes the design.

Clock/Control Distribution Network

Each iCE40 Ultra device has six global inputs, two pins on the top bank and four pins on the bottom bank

These global inputs can be used as high fanout nets, clock, reset or enable signals. The dedicated global pins are identified as Gxx and each drives one of the eight global buffers. The global buffers are identified as GBUF[7:0]. These six inputs may be used as general purpose I/O if they are not used to drive the clock nets.

Table 2-2 lists the connections between a specific global buffer and the inputs on a PLB. All global buffers optionally connect to the PLB CLK input. Any four of the eight global buffers can drive logic inputs to a PLB. Even-numbered global buffers optionally drive the Set/Reset input to a PLB. Similarly, odd-numbered buffers optionally drive the PLB clock-enable input. GBUF[7:6, 3:0] can connect directly to G[7:6, 3:0] pins respectively. GBUF4 and GBUF5 can connect to the two on-chip Oscillator Generators (GBUF4 connects to LFOSC, GBUF5 connects to HFOSC).

Table 2-2. Global Buffer (GBUF) Connections to Programmable Logic Blocks

Global Buffer	LUT Inputs	Clock	Clock Enable	Reset
GBUF0		✓	✓	
GBUF1		✓		✓
GBUF2		✓	✓	
GBUF3	Yes, any 4 of 8	✓		✓
GBUF4	GBUF Inputs	✓	✓	
GBUF5		✓		✓
GBUF6		✓	✓	
GBUF7		✓		✓

The maximum frequency for the global buffers are shown in the iCE40 Ultra External Switching Characteristics tables later in this document.

Global Hi-Z Control
The global high-impedance control signal, GHIZ, connects to all I/O pins on the iCE40 Ultra device. This GHIZ signal is automatically asserted throughout the configuration process, forcing all user I/O pins into their high-impedance state.

Global Reset Control
The global reset control signal connects to all PLB and PIO flip-flops on the iCE40 Ultra device. The global reset signal is automatically asserted throughout the configuration process, forcing all flip-flops to their defined wake-up state. For PLB flip-flops, the wake-up state is always reset, regardless of the PLB flip-flop primitive used in the application.

sysCLOCK Phase Locked Loops (PLLs)

The sysCLOCK PLLs provide the ability to synthesize clock frequencies. The iCE40 Ultra devices have one sys-CLOCK PLL. REFERENCECLK is the reference frequency input to the PLL and its source can come from an external I/O pin, the internal Oscillator Generators from internal routing. EXTFEEDBACK is the feedback signal to the PLL which can come from internal routing or an external I/O pin. The feedback divider is used to multiply the reference frequency and thus synthesize a higher frequency clock output.

The PLLOUT output has an output divider, thus allowing the PLL to generate different frequencies for each output. The output divider can have a value from 1 to 64 (in increments of 2X). The PLLOUT outputs can all be used to drive the iCE40 Ultra global clock network directly or general purpose routing resources can be used.

The LOCK signal is asserted when the PLL determines it has achieved lock and de-asserted if a loss of lock is detected. A block diagram of the PLL is shown in Figure 2-3.

The timing of the device registers can be optimized by programming a phase shift into the PLLOUT output clock which will advance or delay the output clock with reference to the REFERENCECLK clock. This phase shift can be either programmed during configuration or can be adjusted dynamically. In dynamic mode, the PLL may lose lock after a phase adjustment on the output used as the feedback source and not relock until the tLOCK parameter has been satisfied.

There is an additional feature in the iCE40 Ultra PLL. There are 2 FPGA controlled inputs, SCLK and SDI, that allows the user logic to serially shift in data thru SDI, clocked by SCLK clock. The data shifted in would change the configuration settings of the PLL. This feature allows the PLL to be time multiplexed for different functions, with different clock rates. After the data is shifted in, user would simply pulse the RESET input of the PLL block, and the PLL will re-lock with the new settings. For more details, please refer to TN1251, iCE40 sysCLOCK PLL Design and Usage Guide.
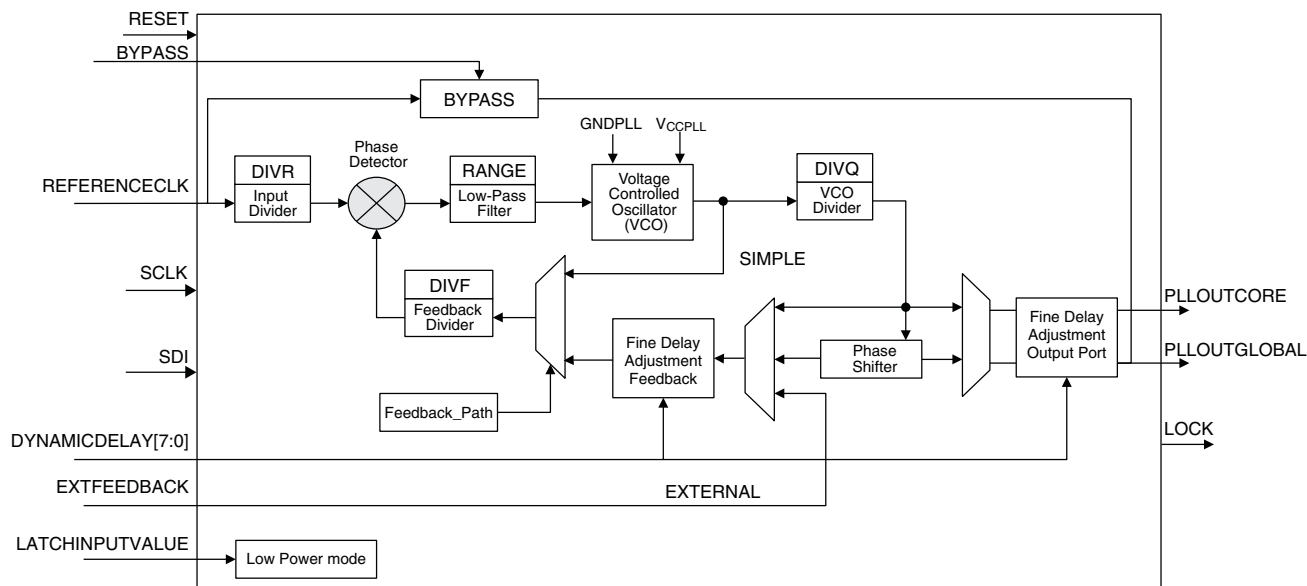
Figure 2-3. PLL Diagram

Table 2-3 provides signal descriptions of the PLL block.

Table 2-4. sysMEM Block Configurations[1]

Block RAM Configuration	Block RAM Configuration and Size	WADDR Port Size (Bits)	WDATA Port Size (Bits)	RADDR Port Size (Bits)	RDATA Port Size (Bits)	MASK Port Size (Bits)
SB_RAM256x16 SB_RAM256x16NR SB_RAM256x16NW SB_RAM256x16NRNW	256x16 (4 k)	8 [7:0]	16 [15:0]	8 [7:0]	16 [15:0]	16 [15:0]
SB_RAM512x8 SB_RAM512x8NR SB_RAM512x8NW SB_RAM512x8NRNW	512x8 (4 k)	9 [8:0]	8 [7:0]	9 [8:0]	8 [7:0]	No Mask Port
SB_RAM1024x4 SB_RAM1024x4NR SB_RAM1024x4NW SB_RAM1024x4NRNW	1024x4 (4 k)	10 [9:0]	4 [3:0]	10 [9:0]	4 [3:0]	No Mask Port
SB_RAM2048x2 SB_RAM2048x2NR SB_RAM2048x2NW SB_RAM2048x2NRNW	2048x2 (4 k)	11 [10:0]	2 [1:0]	11 [10:0]	2 [1:0]	No Mask Port

1. For iCE40 Ultra, the primitive name without "Nxx" uses rising-edge Read and Write clocks. "NR" uses rising-edge Write clock, falling-edge Read clock. "NW" uses falling-edge Write clock and rising-edge Read clock. "NRNW" uses falling-edge clocks on both Read and Write.

sysDSP

The iCE40 Ultra family provides an efficient sysDSP architecture that is very suitable for low-cost Digital Signal Processing (DSP) functions for mobile applications. Typical functions used in these applications are Multiply, Accumulate, and Multiply-Accumulate. The block can also be used for simple Add and Subtract functions.

iCE40 Ultra sysDSP Architecture Features
The iCE40 Ultra sysDSP supports many functions that include the following:

- Single 16-bit x 16-bit Multiplier, or two independent 8-bit x 8-bit Multipliers

- Optional independent pipeline control on Input Register, Output Register, and Intermediate Reg faster clock performance

- Single 32-bit Accumulator, or two independent 16-bit Accumulators

- Single 32-bit, or two independent 16-bit Adder/Subtracter functions, registered or asynchronous

- Cascadable to create wider Accumulator blocks

Figure 2-5 shows the block diagram of the sysDSP block. The block consists Multiplier section, with an bypassable Output register. The Input Register, Intermediate register between Multiplier and AC timing to achieve the highest performance.

Figure 2-5. sysDSP Functional Block Diagram (16-bit x 16-bit Multiply-Accumulate)
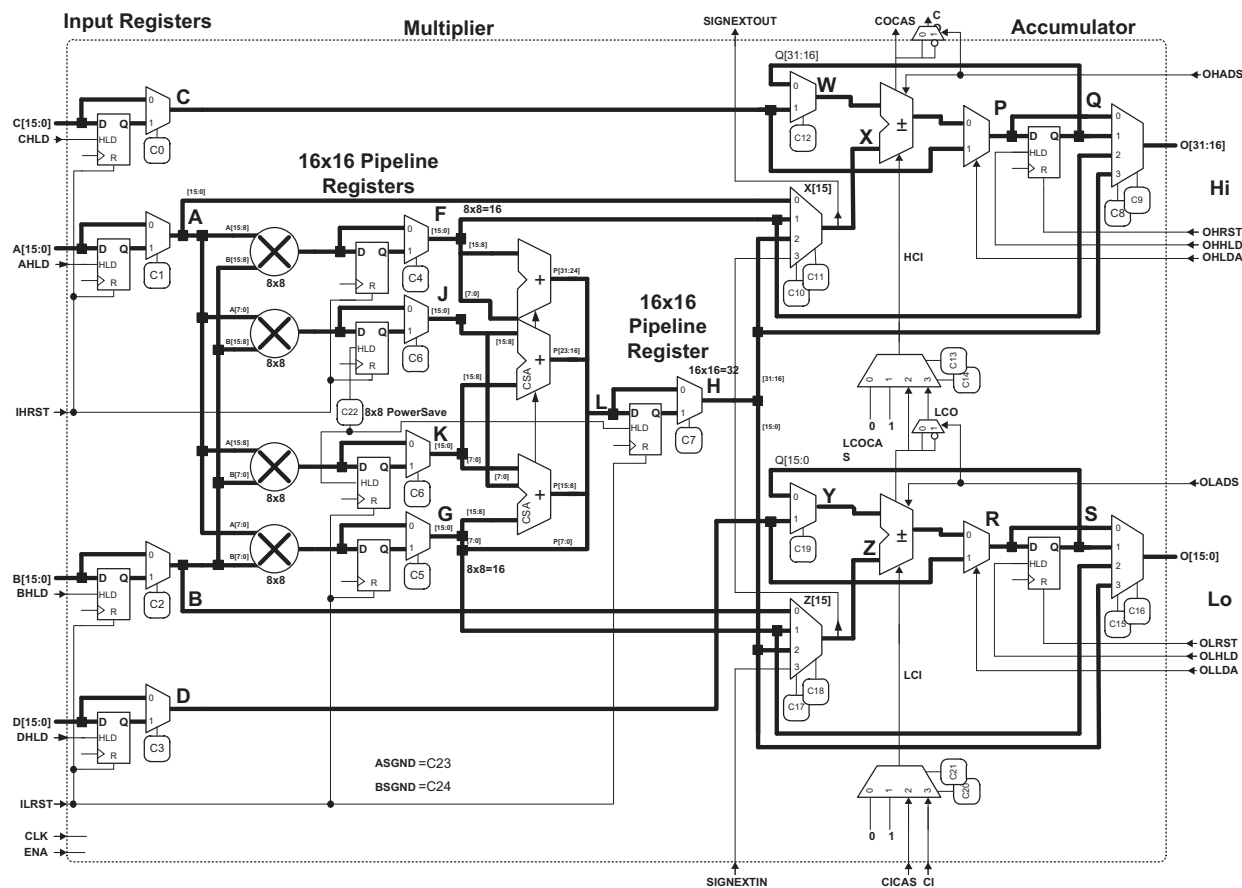
Figure 2-9. iCE I/O Register Block Diagram

= Statically defined by configuration program.
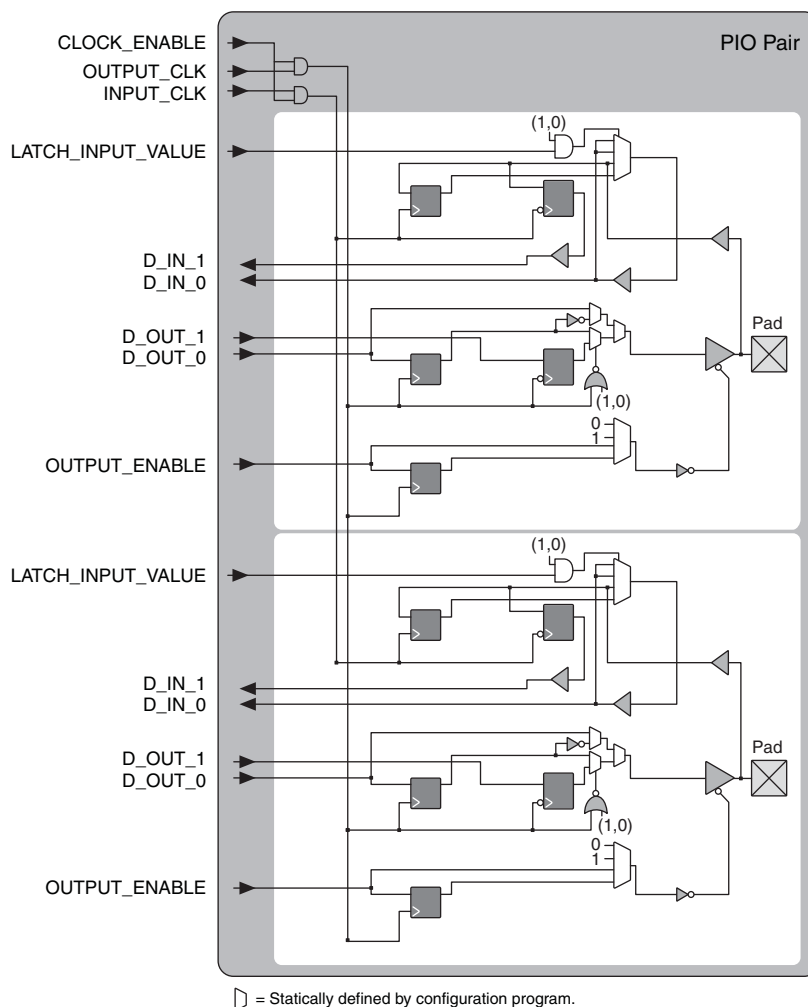
Table 2-7. PIO Signal List

Pin Name	I/O Type	Description
OUTPUT_CLK	Input	Output register clock
CLOCK_ENABLE	Input	Clock enable
INPUT_CLK	Input	Input register clock
OUTPUT_ENABLE	Input	Output enable
D_OUT_0/1	Input	Data from the core
D_IN_0/1	Output	Data to the core
LATCH_INPUT_VALUE	Input	Latches/holds the Input Value

sysIO Buffer

Each I/O is associated with a flexible buffer referred to as a sysIO buffer. These buffers are arranged around the periphery of the device in groups referred to as banks. The sysIO buffers allow users to implement a wide variety of standards that are found in today's systems with LVCMOS interfaces.

Typical I/O Behavior During Power-up

The internal power-on-reset (POR) signal is deactivated when V_{CC}, SPI_V_{CCIO1}, and V_{PP_2V5} reach the level defined in the Power-On-Reset Voltage table in the DC and Switching Characteristics section of this data sheet. After the POR signal is deactivated, the FPGA core logic becomes active. You must ensure that all V_{CCIO} banks are active with valid input logic levels to properly control the output logic states of all the I/O banks that are critical to the application. The default configuration of the I/O pins in a device prior to configuration is tri-stated with a weak pull-up to V_{CCIO}. The I/O pins maintain the pre-configuration state until V_{CC}, SPI_V_{CCIO1}, and V_{PP_2V5} reach the defined levels. The I/Os take on the software user-configured settings only after POR signal is deactivated and the device performs a proper download/configuration. Unused I/Os are automatically blocked and the pull-up termination is disabled.

Supported Standards

The iCE40 Ultra sysIO buffer supports both single-ended input/output standards, and used as differential comparators. The buffer supports the LVCMOS 1.8, 2.5, and 3.3 V standards. The buffer has individually configurable options for bus maintenance (weak pull-up or none).

Table 2-8 and Table 2-9 show the I/O standards (together with their supply and reference voltages) supported by the iCE40 Ultra devices.

Differential Comparators

The iCE40 Ultra devices provide differential comparator on pairs of I/O pins. These comparators are useful in some mobile applications. Please refer to the Pin Information Summary section to locate the corresponding paired I/Os with differential comparators.

Table 2-8. Supported Input Standards

Input Standard	V_{CCIO} (Typical)		
	3.3 V	2.5 V	1.8 V
Single-Ended Interfaces			
LVCMOS33	✓		
LVCMOS25		✓	
LVCMOS18			✓

Table 2-9. Supported Output Standards

Output Standard	V_{CCIO} (Typical)
Single-Ended Interfaces	
LVCMOS33	3.3 V
LVCMOS25	2.5 V
LVCMOS18	1.8 V

On-Chip Oscillator

The iCE40 Ultra devices feature two different frequency Oscillator. One is tailored for low-power operation that runs at low frequency (LFOSC). Both Oscillators are controlled with internally generated current.

The LFOSC runs at nominal frequency of 10 kHz. The high frequency oscillator (HFOSC) runs at a nominal frequency of 48 MHz, divisible to 24 MHz, 12 MHz, or 6 MHz by user option. The LFOSC can be used to perform all always-on functions, with the lowest power possible. The HFOSC can be enabled when the always-on functions detect a condition that would need to wake up the system to perform higher frequency functions.

User I²C IP

The iCE40 Ultra devices have two I²C IP cores. Either of the two cores can be configured either as an I²C master or as an I²C slave. The pins for the I²C interface are not pre-assigned. User can use any General Purpose I/O pins.

In each of the two cores, there are options to delay the either the input or the output, or both, by 50 ns nominal, using dedicated on-chip delay elements. This provides an easier interface with any external I²C components.

When the IP core is configured as master, it will be able to control other devices on the I²C bus through the pre-assigned pin interface. When the core is configured as the slave, the device will be able to provide I/O expansion to an I²C Master. The I²C cores support the following functionality:

- Master and Slave operation
- 7-bit and 10-bit addressing
- Multi-master arbitration support
- Clock stretching
- Up to 400 kHz data transfer speed
- General Call support
- Optionally delaying input or output data, or both

For further information on the User I²C, please refer to TN1274, iCE40 SPI/I2C Hardened IP Usage Guide.

User SPI IP

The iCE40 Ultra devices have two SPI IP cores. The pins for the SPI interface are not pre-assigned. User can use any General Purpose I/O pins. Both SPI IP cores can be configured as a SPI master or as a slave. When the SPI IP core is configured as a master, it controls the other SPI enabled devices connected to the SPI Bus. When SPI IP core is configured as a slave, the device will be able to interface to an external SPI master.

The SPI IP core supports the following functions:

- Configurable Master and Slave modes
- Full-Duplex data transfer
- Mode fault error flag with CPU interrupt capability
- Double-buffered data register
- Serial clock with programmable polarity and phase
- LSB First or MSB First Data Transfer

For further information on the User SPI, please refer to TN1274, iCE40 SPI/I2C Hardened IP Usage Guide.

High Current LED Drive I/O Pins

The iCE40 Ultra family devices offer multiple high current LED drive outputs in each device in the family to allow the iCE40 Ultra product to drive LED signals directly on mobile applications.

There are three outputs on each device that can sink up to 24 mA current. These outputs are open-drain outputs, and provides sinking current to an LED connecting to the positive supply. These three outputs are designed to drive the RBG LEDs, such as the service LED found in a lot of mobile devices. An embedded RGB PWM IP is also offered in the family. This RGB drive current is user programmable from 4 mA to 24 mA, in increments of 4 mA. This output functions as General Purpose I/O with open-drain when the high current LED drive is not needed.

Absolute Maximum Ratings[1, 2, 3]

Supply Voltage V_{CC} . . . . –0.5 V to 1.42 V

Output Supply Voltage V_{CCIO} . . . . –0.5 V to 3.60 V

NVCM Supply Voltage V_{PP_2V5} . . . . –0.5 V to 3.60 V

PLL Supply Voltage V_{CCPLL} . . . . –0.5 V to 1.42 V

I/O Tri-state Voltage Applied. . . . . –0.5 V to 3.60 V

Dedicated Input Voltage Applied . . . . –0.5 V to 3.60 V

Storage Temperature (Ambient). . . . . –65 °C to 150 °C

Junction Temperature (T_J) . . . . –65 °C to 125 °C

1. Stress above those listed under the "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.
2. Compliance with the Lattice Thermal Management document is required.
3. All voltages referenced to GND.

Recommended Operating Conditions[1]

Symbol	Parameter		Min.	Max.	Units
V_{CC}[1]	Core Supply Voltage		1.14	1.26	V
V_{PP_2V5}	VPP_2V5 NVCM Programming and Operating Supply Voltage	Slave SPI Configuration	1.71[4]	3.46	V
		Master SPI Configuration	2.30	3.46	V
		Configuration from NVCM	2.30	3.46	V
		NVCM Programming	2.30	3.00	V
V_{CCIO}[1, 2, 3]	I/O Driver Supply Voltage	V_{CCIO_0}, SPI_V_{CCIO1}, V_{CCIO_2}	1.71	3.46	V
V_{CCPLL}	PLL Supply Voltage		1.14	1.26	V
t_{JCOM}	Junction Temperature Commercial Operation		0	85	°C
t_{JIND}	Junction Temperature Industrial Operation		−40	100	°C
t_{PROG}	Junction Temperature NVCM Programming		10.00	30.00	°C

1. Like power supplies must be tied together if they are at the same supply voltage and they meet the power up sequence requirement. Please refer to Power-Up Supply Sequencing section. V_{CC} and V_{CCPLL} are recommended to tie to same supply with an RC-based noise filter between them. Please refer to TN1252, iCE40 Hardware Checklist.
2. See recommended voltages by I/O standard in subsequent table.
3. V_{CCIO} pins of unused I/O banks should be connected to the V_{CC} power supply on boards.
4. V_{PP_2V5} can, optionally, be connected to a 1.8 V (+/-5%) power supply in Slave SPI Configuration mode subject to the condition that none of the HFOSC/LFOSC and RGB LED / IR LED driver features are used. Otherwise, V_{PP_2V5} must be connected to a power supply with a minimum 2.30 V level.

Power Supply Ramp Rates[1, 2]

Symbol	Parameter	Min.	Max.	Units
t_{RAMP}	Power supply ramp rates for all power supplies.	0.6	10	V/ms

1. Assumes monotonic ramp rates.
2. Power up sequence must be followed. Please refer to Power-Up Supply Sequencing section.

Power-On Reset

All iCE40 Ultra devices have on-chip Power-On-Reset (POR) circuitry to ensure proper initialization of the device. Only three supply rails are monitored by the POR circuitry as follows: (1) V_{CC}, (2) SPI_V_{CCIO1} and (3) V_{PP_2V5}. All other supply pins have no effect on the power-on reset feature of the device. Note that all supply voltage pins must be connected to power supplies for normal operation (including device configuration).

Power-Up Supply Sequencing

It is recommended to bring up the power supplies in the following order. Note that there is no specified timing delay between the power supplies, however, there is a requirement for each supply to reach a level of 0.5V, or higher, before any subsequent power supplies in the sequence are applied.

1. **V_{CC}** and **V_{CCPLL}** should be the first two supplies to be applied. Note that these two supplies can be tied together subject to the recommendation to include a RC-based noise filter on the V_{CCPLL} (Please refer to TN1252, iCE40 Hardware Checklist.)

2. **SPI_V_{CCIO1}** should be the next supply, and can be applied any time after the previous supplies (V_{CC} and V_{CCPLL}) have reached as level of 0.5 V or higher.

3. **V_{PP_2V5}** should be the next supply, and can be applied any time after previous supplies (V_{CC}, V_{CCPLL} and SPI_V_{CCIO1}) have reached a level of 0.5 V or higher.

4. **Other Supplies** (V_{CCIO0} and V_{CCIO2}) do not affect device power-up functionality, and they can be applied any time after the initial power supplies (V_{CC} and V_{CCPLL}) have reached a level of 0.5 V or greater.

There is no power down sequence required. However, when partial power supplies are powered down, it is required the above sequence to be followed when these supplies are repowered up again.

External Reset

When all power supplies have reached to their minimum operating voltage defined in Minimum Operation Condition Table, it is required to either keep CRESET_B LOW, or toggle CRESET_B from HIGH to LOW, for a duration of t_{CRESET_B}, and release it to go HIGH, to start configuration download from either the internal NVCM or the external Flash memory.

Figure 3-1 shows Power-Up sequence when SPI_V_{CCIO1} and V_{PP_2V5} are connected separately, and the CRESET_B signal triggers configuration download. Figure 3-2 shows when SPI_V_{CCIO1} and V_{PP_2V5} connected together.

All power supplies should be powered up during configuration. Before and during configuration, the I/Os are held in tri-state. I/Os are released to user functionality once the device has finished configuration.

Figure 3-1. Power Up Sequence with SPI_V_{CCIO1} and V_{PP_2V5} Not Connected Together
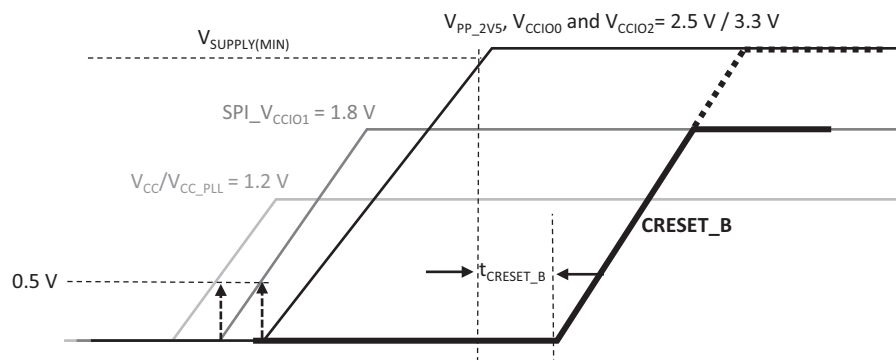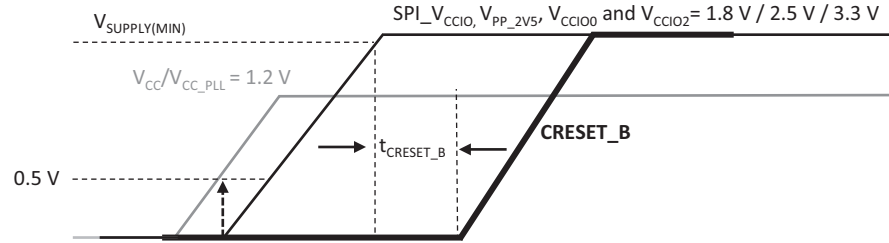
Figure 3-2. Power Up Sequence with All Supplies Connected Together

Power-On-Reset Voltage Levels[1]

Symbol	Parameter		Min.	Max.	Units
V$_{PORUP}$	Power-On-Reset ramp-up trip point (circuit monitoring V$_{CC}$, SPI_V$_{CCIO1}$, V$_{PP\_2V5}$)	V$_{CC}$	0.62	0.92	V
		SPI_V$_{CCIO1}$	0.87	1.50	V
		V$_{PP\_2V5}$	0.90	1.53	V
V$_{PORDN}$	Power-On-Reset ramp-down trip point (circuit monitoring V$_{CC}$, SPI_V$_{CCIO1}$, V$_{PP\_2V5}$)	V$_{CC}$	—	0.79	V
		SPI_V$_{CCIO1}$	—	1.50	V
		V$_{PP\_2V5}$	—	1.53	V

1. These POR trip points are only provided for guidance. Device operation is only characterized for power supply voltages specified under recommended operating conditions.

ESD Performance

Please contact Lattice Semiconductor for additional information.

DC Electrical Characteristics

Over Recommended Operating Conditions

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
I$_{IL}$, I$_{IH}$[1, 3, 4]	Input or I/O Leakage	0V < V$_{IN}$ < V$_{CCIO}$ + 0.2 V	—	—	+/−10	μA
C$_1$	I/O Capacitance, excluding LED Drivers[2]	V$_{CCIO}$ = 3.3 V, 2.5 V, 1.8 V V$_{CC}$ = Typ., V$_{IO}$ = 0 to V$_{CCIO}$ + 0.2 V	—	6	—	pF
C$_2$	Global Input Buffer Capacitance[2]	V$_{CCIO}$ = 3.3 V, 2.5 V, 1.8 V V$_{CC}$ = Typ., V$_{IO}$ = 0 to V$_{CCIO}$ + 0.2 V	—	6	—	pF
C$_3$	RGB Pin Capacitance[2]	V$_{CC}$ = Typ., V$_{IO}$ = 0 to 3.5 V	—	15	—	pF
C$_4$	IRLED Pin Capacitance[2]	V$_{CC}$ = Typ., V$_{IO}$ = 0 to 3.5 V	—	53	—	pF
V$_{HYST}$	Input Hysteresis	V$_{CCIO}$ = 1.8 V, 2.5 V, 3.3 V	—	200	—	mV
I$_{PU}$	Internal PIO Pull-up Current	V$_{CCIO}$ = 1.8 V, 0=<V$_{IN}$<=0.65 V$_{CCIO}$	−3	—	−31	μA
		V$_{CCIO}$ = 2.5 V, 0=<V$_{IN}$<=0.65 V$_{CCIO}$	−8	—	−72	μA
		V$_{CCIO}$ = 3.3 V, 0=<V$_{IN}$<=0.65 V$_{CCIO}$	−11	—	−128	μA

1. Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tri-stated. It is not measured with the output driver active. Internal pull-up resistors are disabled.
2. T$_J$ 25 °C, f = 1.0 MHz.
3. Please refer to V$_{IL}$ and V$_{IH}$ in the sysIO Single-Ended DC Electrical Characteristics table of this document.
4. Input pins are clamped to V$_{CCIO}$ and GND by a diode. When input is higher than V$_{CCIO}$ or lower than GND, the Input Leakage current will be higher than the I$_{IL}$ and I$_{IH}$.

Typical Building Block Function Performance[1, 2]

Pin-to-Pin Performance (LVCMOS25)

Function	Timing	Units
Basic Functions		
16-bit decoder	16.5	ns
4:1 MUX	18.0	ns
16:1 MUX	19.5	ns

Register-to-Register Performance

Function	Timing	Units
Basic Functions		
16:1 MUX	110	MHz
16-bit adder	100	MHz
16-bit counter	100	MHz
64-bit counter	40	MHz
Embedded Memory Functions		
256x16 Pseudo-Dual Port RAM	150	MHz

1. The above timing numbers are generated using the Lattice Design Software tool. Exact performance may vary with device and tool version. The tool uses internal parameters that have been characterized but are not tested on every device.
2. Under worst case operating conditions.

Derating Logic Timing

Logic timing provided in the following sections of the data sheet and the Lattice design tools are worst case numbers in the operating range. Actual delays may be much faster. Lattice design tools can provide logic timing numbers at a particular temperature and voltage.

Maximum sysIO Buffer Performance[1]

I/O Standard	Max. Speed	Units
Inputs		
LVCMOS33	250	MHz
LVCMOS25	250	MHz
LVCMOS18	250	MHz
Outputs		
LVCMOS33	250	MHz
LVCMOS25	250	MHz
LVCMOS18	155	MHz

1. Measured with a toggling pattern

SPI Master or NVCM Configuration Time[1, 2]

Symbol	Parameter	Conditions	Max.	Units
t_{CONFIG}	POR/CRESET_B to Device I/O Active	All devices – Low Frequency (Default)	95	ms
		All devices – Medium frequency	35	ms
		All devices – High frequency	18	ms

1. Assumes sysMEM Block is initialized to an all zero pattern if they are used.
2. The NVCM download time is measured with a fast ramp rate starting from the maximum voltage of POR trip point.

sysCONFIG Port Timing Specifications

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
All Configuration Modes						
t_{CRESET_B}	Minimum CRESET_B LOW pulse width required to restart configuration, from falling edge to rising edge		200	—	—	ns
t_{DONE_IO}	Number of configuration clock cycles after CDONE goes HIGH before the PIO pins are activated		49	—	—	Clock Cycles
Slave SPI						
t_{CR_SCK}	Minimum time from a rising edge on CRESET_B until the first SPI WRITE operation, first SPI_XCK clock. During this time, the iCE40 Ultra device is clearing its internal configuration memory		1200	—	—	µs
f_{MAX}	CCLK clock frequency	Write	1	—	25	MHz
		Read[1]	—	15	—	MHz
t_{CCLKH}	CCLK clock pulsewidth HIGH		20	—	—	ns
t_{CCLKL}	CCLK clock pulsewidth LOW		20	—	—	ns
t_{STSU}	CCLK setup time		12	—	—	ns
t_{STH}	CCLK hold time		12	—	—	ns
t_{STCO}	CCLK falling edge to valid output		13	—	—	ns
Master SPI[3]						
f_{MCLK}	MCLK clock frequency	Low Frequency (Default)	7.0	12.0	17.0	MHz
		Medium Frequency[2]	21.0	33.0	45.0	MHz
		High Frequency[2]	33.0	53.0	71.0	MHz
t_{MCLK}	CRESET_B HIGH to first MCLK edge		1200	—	—	µs
t_{SU}	CCLK setup time[4]		9.9	—	—	ns
t_{HD}	CCLK hold time		1	—	—	ns

1. Supported with 1.2 V Vcc and at 25 ºC.
2. Extended range fMAX Write operations support up to 53 MHz with 1.2 V Vcc and at 25 ºC.
3. t_{SU} and t_{HD} timing must be met for all MCLK frequency choices.
4. For considerations of SPI Master Configuration Mode, please refer to TN1248, iCE40 Programming and Configuration.

RGB LED and IR LED Drive

Symbol	Parameter	Min.	Max.	Units
ILED_ACCURACY	RGB0, RGB1, RGB2 Sink Current Accuracy to selected current @ V_{LEDOUT} >= 0.5 V	−12	+12	%
ILED_MATCH	RGB0, RGB1, RGB2 Sink Current Matching among the 3 outputs @ V_{LEDOUT} >= 0.5 V	−5	+5	%
IIR_ACCURACY	IR LED Sink Current Accuracy to selected current @ V_{IROUT} >= 0.8 V	−14	+14	%

Switching Test Conditions

Figure 3-3 shows the output test load used for AC testing. The specific values for resistance, capacitance, voltage, and other test conditions are shown in Table 3-1.

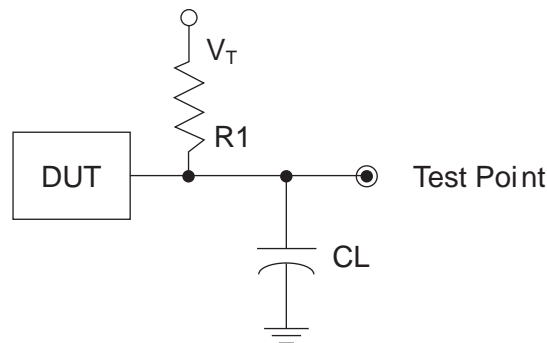*Figure 3-3. Output Test Load, LVCMOS Standards*

Table 3-1. Test Fixture Required Components, Non-Terminated Interfaces

Test Condition	R_1	C_L	Timing Reference	V_T
LVCMOS settings (L -> H, H -> L)	∞	0 pF	LVCMOS 3.3 = 1.5 V	—
			LVCMOS 2.5 = V_{CCIO}/2	—
			LVCMOS 1.8 = V_{CCIO}/2	—
LVCMOS 3.3 (Z -> H)	188	0 pF	1.5 V	V_{OL}
LVCMOS 3.3 (Z -> L)			1.5 V	V_{OH}
Other LVCMOS (Z -> H)			V_{CCIO}/2	V_{OL}
Other LVCMOS (Z -> L)			V_{CCIO}/2	V_{OH}
LVCMOS (H -> Z)			V_{OH} − 0.15 V	V_{OL}
LVCMOS (L -> Z)			V_{OL} − 0.15 V	V_{OH}

Note: Output test conditions for all other interfaces are determined by the respective standards.
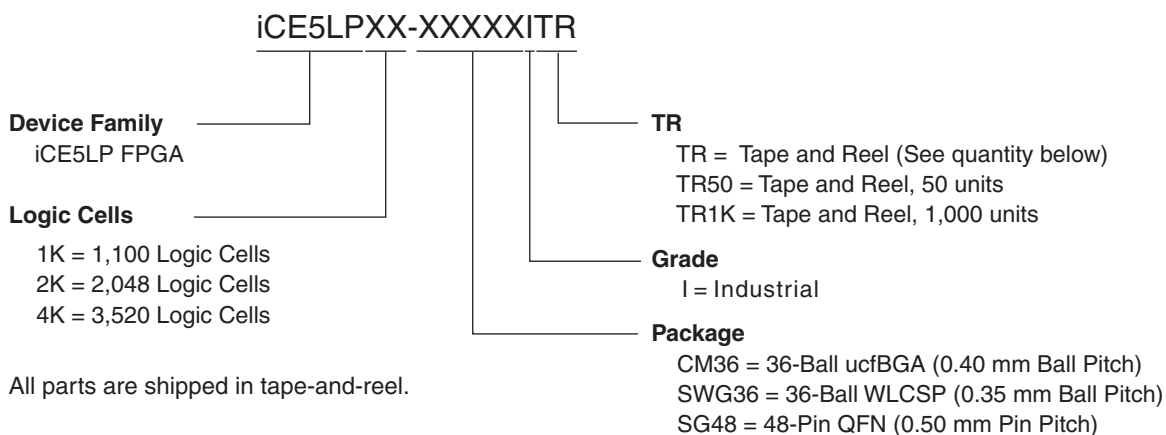
Signal Name		Function	I/O	Description
PIOB_33b	SPI_SI	Configuration	Input	This pin is shared with device configuration. During configuration: In Master SPI mode, this pin receives data from external SPI memory. In Slave SPI mode, this pin connects to the MOSI pin of the external processor.
		General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function.
PIOB_35b	SPI_SS_B	Configuration	I/O	This pin is shared with device configuration. During configuration: In Master SPI mode, this pin outputs to the external SPI memory. In Slave SPI mode, this pin inputs from the external processor.
		General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function.
Global Signals				
Primary	Secondary			
PIOT_46b	G0	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G0 pin drives the GBUF0 global buffer
PIOT_45a	G1	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G1 pin drives the GBUF1 global buffer
PIOT_25b	G3	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G3 pin drives the GBUF3 global buffer
PIOT_12a	G4	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G4 pin drives the GBUF4 global buffer
PIOT_11b	G5	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G5 pin drives the GBUF5 global buffer
PIOB_3b	G6	General I/O	I/O	In user mode, after configuration, this pin can be programmed as general I/O in user function
		Global	Input	Global input used for high fanout, or clock/reset net. The G6 pin drives the GBUF6 global buffer
LED Signals				
RGB0		General I/O	Open-Drain I/O	In user mode, with user's choice, this pin can be programmed as open drain I/O in user function
		LED	Open-Drain Output	In user mode, with user's choice, this pin can be programmed as open drain 24mA output to drive external LED
RGB1		General I/O	Open-Drain I/O	In user mode, with user's choice, this pin can be programmed as open drain I/O in user function
		LED	Open-Drain Output	In user mode, with user's choice, this pin can be programmed as open drain 24mA output to drive external LED

Pin Information Summary

Pin Type		iCE5LP1K			iCE5LP2K			iCE5LP4K		
		CM36	SWG36	SG48[1]	CM36	SWG36	SG48[1]	CM36	SWG36	SG48[1]
General Purpose I/O Per Bank	Bank 0	12	5	17	12	5	17	12	5	17
	Bank 1	4	15	14	4	15	14	4	15	14
	Bank 2	10	6	8	10	6	8	10	6	8
Total General Purpose I/Os		26	26	39	26	26	39	26	26	39
V_{CC}		1	1	2	1	1	2	1	1	2
V_{CCIO}	Bank 0	1	1	1	1	1	1	1	1	1
	Bank 1	1	1	1	1	1	1	1	1	1
	Bank 2	1	1	1	1	1	1	1	1	1
V_{CCPLL}		1	1	1	1	1	1	1	1	1
V_{PP_2V5}		1	1	1	1	1	1	1	1	1
Dedicated Config Pins		1	1	2	1	1	2	1	1	2
GND		2	2	0	2	2	0	2	2	0
GND_LED		1	1	0	1	1	0	1	1	0
Total Balls		36	36	48	36	36	48	36	36	48

1. 48-pin QFN package (SG48) requires the package paddle to be connected to GND.

iCE5LP Part Number Description

iCE5LPXX-XXXXXITR

Device Family
iCE5LP FPGA

Logic Cells
1K = 1,100 Logic Cells
2K = 2,048 Logic Cells
4K = 3,520 Logic Cells

All parts are shipped in tape-and-reel.

TR
TR = Tape and Reel (See quantity below)
TR50 = Tape and Reel, 50 units
TR1K = Tape and Reel, 1,000 units

Grade
I = Industrial

Package
CM36 = 36-Ball ucfBGA (0.40 mm Ball Pitch)
SWG36 = 36-Ball WLCSP (0.35 mm Ball Pitch)
SG48 = 48-Pin QFN (0.50 mm Pin Pitch)

Tape and Reel Quantity

Package	TR Quantity
CM36	4,000
SWG36	5,000
SG48	2,000

Date	Version	Section	Change Summary
June 2016	2.0	Introduction	Updated General Description section. Changed "high current driver" to "high current IR driver".
			Updated Features section. In Table 1-1, iCE40 Ultra Family Selection Guide, corrected HF Oscillator (48 kHz) to (48 MHz).
		Architecture	Updated Architecture Overview section. — Changed content to "The Programmable Logic Blocks (PLB) and sysMEM EBR blocks, are arranged in a two-dimensional grid with rows and columns. Each column has either PLB or EBR blocks." — Changed "high current LED sink" to "high current RGB and IR LED sinks".
			Updated sysCLOCK Phase Locked Loops (PLLs) section. Corrected V_{CCPLL} character format in Figure 2-3, PLL Diagram.
			Updated sysMEM Embedded Block RAM Memory section. Updated footnote in Table 2-4, sysMEM Block Configurations.
			Updated sysIO Buffer Banks section. — Changed statement to "The configuration SPI interface signals are powered by SPI_V_{CCIO1}." — Corrected V_{CCIO} character format in Figure 2-8, I/O Bank and Programmable I/O Cell.
			Updated Typical I/O Behavior During Power-up section. Modified text content.
			Updated Supported Standards section. Changed statement to "The iCE40 Ultra sysIO buffer supports both single-ended input/output standards, and used as differential comparators."
			Updated On-Chip Oscillator section. Changed statement to "The high frequency oscillator (HFOSC) runs at a nominal frequency of 48 MHz, divisible to 24 MHz, 12 MHz, or 6 MHz by user option."
			Updated section heading to High Current LED Drive I/O Pins. Changed "high current drive" to "high current LED drive".
			Removed Power On Reset section.
		DC and Switching Characteristics	Updated Absolute Maximum Ratings section. — Corrected symbol character format.
			Updated Recommended Operating Conditions section. — Corrected symbol character format. — Revised footnote 1. — Added footnote 4.
			Updated Power Supply Ramp Rates section. Changed t_{RAMP} Max. value.
			Added Power-On Reset section.
			Updated section heading to Power-Up Supply Sequencing. Revised text content.
			Added External Reset section.
			Updated DC Electrical Characteristics section. Revised footnote 4.

Date	Version	Section	Change Summary
August 2014	1.4	All	Removed Preliminary document status.
		Introduction	Updated General Description section. Added information on high current driver.
			Updated Features section. — Changed standby current typical to as low as 71 µA. — Changed feature to Embedded Memory. — Updated Table 1-1, iCE40 Ultra Family Selection Guide. Added NVCM and Embedded PWM IP rows. Added (MULT16 with 32-bit Accumulator) to DSP Block. Added Total I/O (Dedicated I/O) Count data.
			General update to Introduction section.
		Architecture	Updated Architecture Overview section. — Revised and added information on sysIO banks. — Updated reference for embedded PWM IP.
			Updated iCE40 Ultra Programming and Configuration section. — Changed SPI1 to SPI. — Changed VCCIO_1 to SPI_V_{CCIO1}.
		DC and Switching Characteristics	Updated Absolute Maximum Ratings section. Changed PLL Supply Voltage VCCPLL value.
			Updated Recommended Operating Conditions section. Added footnote to VCCPLL.
			Updated Power-up Sequence section. General update.
			Updated Power-On-Reset Voltage Levels section. Changed the V_{PORUP} V_{CC} Max.value.
			Updated DC Electrical Characteristics section. Added C_3 and C_4 information.
			Updated Supply Current section. — Completed Typ. VCC =1.2 V4 data. — Changed symbols to $I_{SPI\_VCCIO1STDBY}$ and $I_{SPI\_VCCIO1PEAK}$. — Added information to footnote 3.
			Updated Internal Oscillators (HFOSC, LFOSC) section. General update.
			Updated iCE40 Ultra External Switching Characteristics section. Added Max. value for t_{COPLL}. Added Min. values for t_{SUPLL} and t_{HPLL}.
			Updated sysCLOCK PLL Timing section. Added Max. value for t_{OPJIT}.
			Updated sysCONFIG Port Timing Specifications section. — Added T_{SU} and T_{HD} information. — Added footnote 3 to Master SPI.
			Updated High Current LED and IR LED Drive section. Updated Min. value.
July 2014	1.3	All	Changed document status from Advance to Preliminary.
		Introduction	Updated Features section. Adjusted Ultra-low Power Devices standby current.
		DC and Switching Characteristics	Updated AC/DC specifications numbers.

Date	Version	Section	Change Summary
June 2014	1.2	All	Product name changed to iCE40 Ultra.
		Introduction	Updated Table 1-1, iCE40 Ultra Family Selection Guide. Removed 30-ball WLCSP.
		DC and Switching Characteristics	Updated values in the following sections: — Supply Current — Internal Oscillators (HFOSC, LFOSC) — Power Supply Ramp Rates — Power-On-Reset Voltage Levels — SPI Master or NVCM Configuration Time
			Indicated TBD for values to be determined.
		Pinout Information	Updated Signal Descriptions section. Removed 30-pin WLCSP.
			Updated Pin Information Summary section. Removed SWG30 values.
		Ordering Information	Updated iCE5LP Part Number Description section. Removed 30-ball WLCSP.
			Updated Ordering Part Numbers section. Removed SWG30 and UWG30 part numbers.
May 2014	01.1	Introduction	Updated General Description, Features, and Introduction sections. Removed hardened RGB PWM IP information.
		Architecture	Updated Architecture Overview section. Removed the RGB IP block in Figure 2-1, iCE5LP-4K Device, Top View, Figure 2-8, I/O Bank and Pro-grammable I/O, and in the text content.
			Updated High Current Drive I/O Pins section. Removed hardened RGB PWM IP information.
			Updated Power On Reset section. Removed content on Vccio_2 power down option.
			Replaced RGB PWM Block section with Embedded PWM IP section.
		DC and Switching Characteristics	Removed RGB PWM Block Timing section.
April 2014	01.0	All	Initial release.